



flowPACK 1

1200 V / 15 A

Topology features

- 3ph Vienna rectifier
- Inverter
- Open Emitter configuration
- Temperature sensor

Component features

- Easy paralleling
- Low turn-off losses
- Low collector emitter saturation voltage
- Positive temperature coefficient
- Short tail current
- Switching optimized for EMC

Housing features

- Base isolation: Al₂O₃
- Convex shaped substrate for superior thermal contact
- Thermo-mechanical push-and-pull force relief

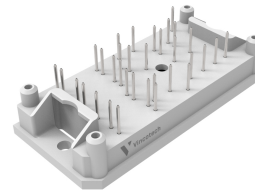
Target applications

- Embedded Drives
- Industrial Drives

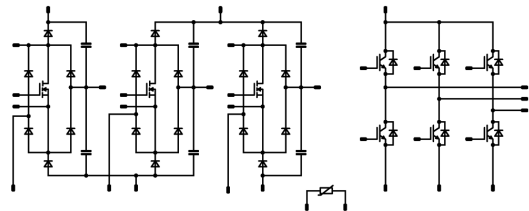
Types

- 10-F112VPA015M7-LK88A74

flow 1 17 mm housing



Schematic



**Maximum Ratings** $T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Inverter Switch				
Collector-emitter voltage	V_{CES}		1200	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	22	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	30	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	60	W
Gate-emitter voltage	V_{GES}		± 20	V
Short circuit ratings	i_{SC}	$V_{GE} = 15\text{ V}$, $V_{CC} = 800\text{ V}$ $T_j = 150\text{ °C}$	9,5	μs
Maximum junction temperature	T_{jmax}		175	$^{\circ}\text{C}$

Inverter Diode

Peak repetitive reverse voltage	V_{RRM}		1200	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	22	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	30	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	45	W
Maximum junction temperature	T_{jmax}		175	$^{\circ}\text{C}$



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Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Boost Switch				
Drain-source voltage	V_{DS}		600	V
Drain current (DC current)	I_D	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	15	A
Peak drain current	I_{DM}	I_p limited by T_{jmax}	100	A
Avalanche energy, single pulse	E_{AS}	$V_{DD} = 50\text{ V}$ $I_D = 5,1\text{ A}$	105	mJ
Avalanche energy, repetitive	E_{AR}	$V_{DD} = 50\text{ V}$ $I_D = 5,1\text{ A}$	0,53	mJ
MOSFET dv/dt ruggedness	dv/dt	$V_{DS} = 0..400\text{ V}$ $T_s = 25\text{ °C}$	80	V/ns
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	45	W
Gate-source voltage	V_{GS}		±20	V
Reverse diode dv/dt	dv/dt		50	V/ns
Maximum Junction Temperature	T_{jmax}		150	°C

Boost Diode

Peak repetitive reverse voltage	V_{RRM}		600	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	22	A
Surge (non-repetitive) forward current	I_{FSM}	$T_j = 25\text{ °C}$	150	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	41	W
Maximum junction temperature	T_{jmax}		150	°C

Rectifier Diode

Peak repetitive reverse voltage	V_{RRM}		1600	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	27	A
Surge (non-repetitive) forward current	I_{FSM}	Single Half Sine Wave, $t_p = 8,3\text{ ms}$	150	A
Surge current capability	I^2t		$T_j = 25\text{ °C}$	112
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	34	W
Maximum junction temperature	T_{jmax}		150	°C



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Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Capacitor (DC)				
Maximum DC voltage	V_{MAX}		630	V
Operation Temperature	T_{op}		-55 ... 125	°C

Module Properties

Thermal Properties

Storage temperature	T_{stg}		-40...+125	°C
Operation temperature under switching condition	T_{jop}		-40...+($T_{jmax} - 25$)	°C

Isolation Properties

Isolation voltage	V_{isol}	DC Test Voltage* $t_p = 2\text{ s}$	6000	V
Isolation voltage	V_{isol}	AC Voltage $t_p = 1\text{ min}$	2500	V
Creepage distance			>12,7	mm
Clearance			12,67	mm
Comparative Tracking Index	CTI		≥ 200	

*100 % tested in production



Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		

Inverter Switch

Static

Gate-emitter threshold voltage	$V_{GE(th)}$		10	0,0015	25	5,4	6	6,6	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	15		15	25 125 150		1,7 1,95 2,01	2,1 ⁽¹⁾	V
Collector-emitter cut-off current	I_{CES}	0	1200		25			60	μA
Gate-emitter leakage current	I_{GES}	0	0		25			200	nA
Internal gate resistance	r_g						None		Ω
Input capacitance	C_{ies}						2900		pF
Output capacitance	C_{oes}	0	10		25		120		pF
Reverse transfer capacitance	C_{res}						34		pF
Gate charge	Q_g	$V_{CC} = 600$ V	0/15		15	25		110	nC

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)						1,6	K/W
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Dynamic

Turn-on delay time	$t_{d(on)}$	$R_{gon} = 21,3$ Ω $R_{goff} = 21,3$ Ω	±15	600	15	25		140,8		ns				
						125		138,24						
						150		137,92						
Rise time	t_r									25		39,04		ns
										125		42,56		
										150		45,12		
Turn-off delay time	$t_{d(off)}$									25		158,4		ns
										125		180,16		
						150		181,76						
Fall time	t_f					25		99,01		ns				
						125		116,66						
						150		117,1						
Turn-on energy (per pulse)	E_{on}	$Q_{tFWD} = 1,42$ μC $Q_{tFWD} = 2,24$ μC $Q_{tFWD} = 2,57$ μC				25		1,32		mWs				
						125		1,69						
						150		1,89						
Turn-off energy (per pulse)	E_{off}					25		1,06		mWs				
						125		1,41						
						150		1,53						



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		
Inverter Diode										
Static										
Forward voltage	V_F			15	25 125 150		1,63 1,74 1,73	1,9 ⁽¹⁾		V
Reverse leakage current	I_R	$V_r = 1200$ V			25			30		μA
Thermal										
Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)					2,11			K/W
Dynamic										
Peak recovery current	I_{RRM}				25 125 150		11,37 12,4 12,74			A
Reverse recovery time	t_{rr}				25 125 150		252,95 381,91 431,74			ns
Recovered charge	Q_r	$di/dt=299$ A/μs $di/dt=278$ A/μs $di/dt=291$ A/μs	±15	600	15	25 125 150	1,42 2,24 2,57			μC
Reverse recovered energy	E_{rec}				25 125 150		0,499 0,847 0,983			mWs
Peak rate of fall of recovery current	$(di_r/dt)_{max}$				25 125 150		104,91 69,84 62,53			A/μs



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		

Boost Switch

Static

Drain-source on-state resistance	$r_{DS(on)}$	10		10,5	25 125		94,4 168	99 ⁽¹⁾	mΩ
Gate-source threshold voltage	$V_{GS(th)}$	0		0,00053	25	3	3,5	4	V
Gate to Source Leakage Current	I_{GSS}	20	0		25			100	nA
Zero Gate Voltage Drain Current	I_{DSS}	0	600		25			1	μA
Internal gate resistance	r_g						5,9		Ω
Gate charge	Q_g	0/10	400	10,5	25		45		nC
Short-circuit input capacitance	C_{iss}	$f = 250$ kHz	0	400	0	25		1952	pF
Short-circuit output capacitance	C_{oss}							33	

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)					1,57		K/W
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Dynamic

Turn-on delay time	$t_{d(on)}$	$R_{gon} = 16$ Ω $R_{goff} = 16$ Ω	0/10	400	15	25		35,84		ns
Rise time	t_r					125		33,6		
						25		9,28		ns
Turn-off delay time	$t_{d(off)}$					125		10,24		
						25		132,8		ns
Fall time	t_f					125		146,56		
						25		6,52		ns
Turn-on energy (per pulse)	E_{on}	125		7,06						
		25		0,122		mWs				
Turn-off energy (per pulse)	E_{off}	125		0,239						
		25		0,086		mWs				
							0,098			



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		

Boost Diode

Static

Forward voltage	V_F				15	25 125	1,88	2,47 1,73	2,73 ⁽¹⁾	V
Reverse leakage current	I_R	$V_i = 600$ V				25			100	μA

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)						1,71		K/W
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Dynamic

Peak recovery current	I_{RRM}	$di/dt=1962$ A/μs $di/dt=1704$ A/μs	0/10	400	15	25		16,98		A
						125		24,21		
Reverse recovery time	t_{rr}					25		14,8		ns
						125		33,06		
Recovered charge	Q_r					25		0,146		μC
						125		0,444		
Reverse recovered energy	E_{rec}	25		0,043		mWs				
		125		0,099						
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$	25		4283		A/μs				
		125		1773						



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GS} [V]	V_{GE} [V]	V_{DS} [V]	V_{CE} [V]	T_j [°C]	Min	Typ	Max	

Rectifier Diode

Static

Forward voltage	V_F				7	25 125 150		1,01 0,922	1,11 ⁽¹⁾ 1,01 ⁽¹⁾	V
Reverse leakage current	I_R	$V_r = 1600$ V				25 150			5 700	μA

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)						2,03		K/W
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Capacitor (DC)

Static

Capacitance	C	DC bias voltage = 0 V				25		47		nF
Tolerance							-10		10	%
Dissipation factor		$f = 1$ kHz				25		2,5		%



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GS} [V]	V_{GE} [V]	V_{DS} [V]	V_{CE} [V]	T_j [°C]	Min	Typ	Max	

Thermistor

Static

Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$A_{R/R}$	$R_{100} = 1484 \Omega$				100	-5		5	%
Power dissipation	P					25		130		mW
Power dissipation constant	d					25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. $\pm 1 \%$						3962		K
B-value	$B_{(25/100)}$	Tol. $\pm 1 \%$						4000		K
Vincotech Thermistor Reference									I	

⁽¹⁾ Value at chip level

⁽²⁾ Only valid with pre-applied Vincotech thermal interface material.

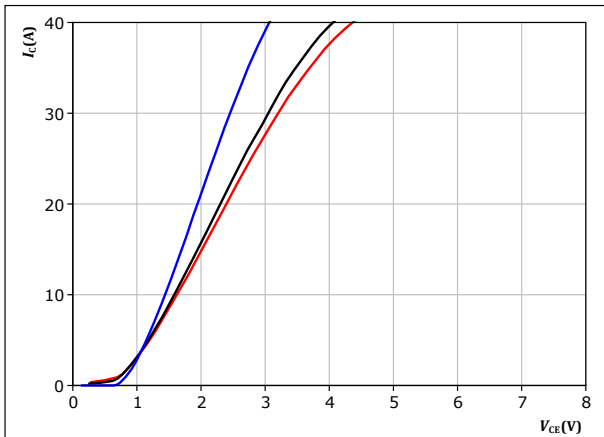


Inverter Switch Characteristics

figure 1. IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

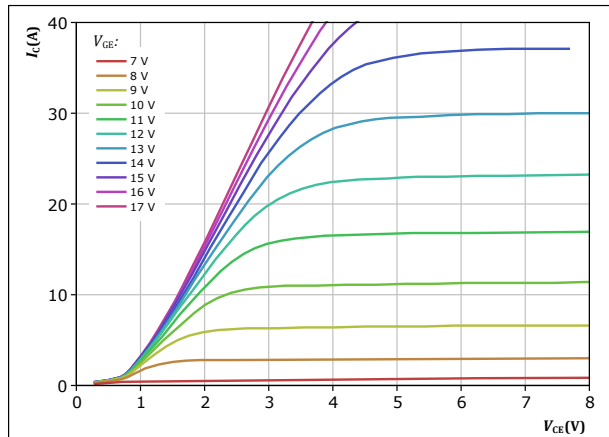


$t_p = 250 \mu s$
 $V_{GE} = 15 V$
 $T_j:$ 25 °C, 125 °C, 150 °C

figure 2. IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

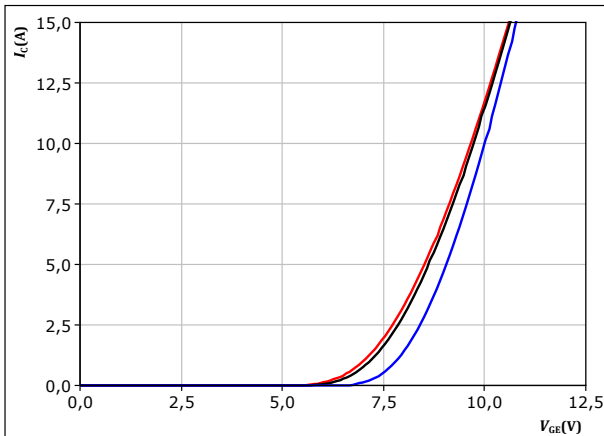


$t_p = 250 \mu s$
 $T_j = 150 \text{ °C}$
 V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. IGBT

Typical transfer characteristics

$$I_C = f(V_{GE})$$

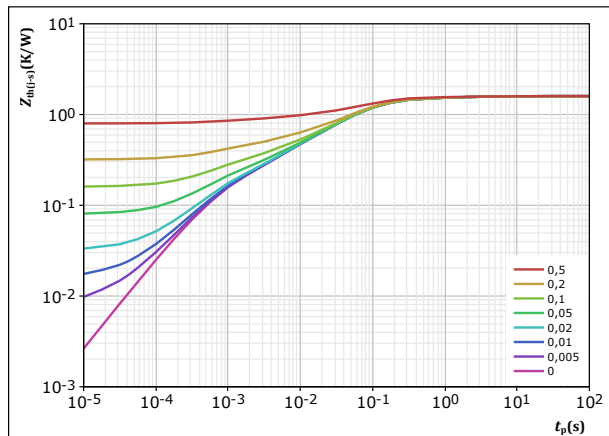


$t_p = 250 \mu s$
 $V_{CE} = 10 V$
 $T_j:$ 25 °C, 125 °C, 150 °C

figure 4. IGBT

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$
 $R_{th(j-s)} = 1,595 \text{ K/W}$
IGBT thermal model values

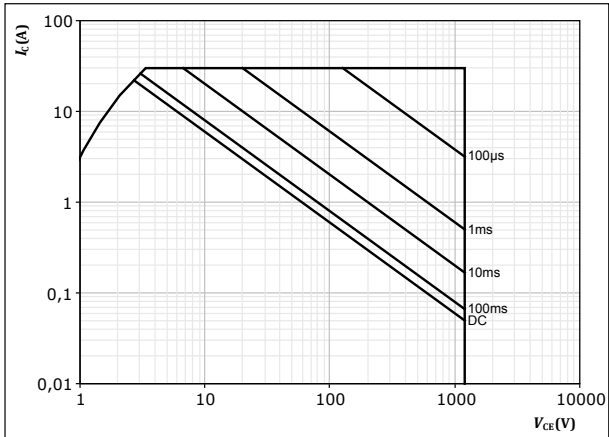
R (K/W)	τ (s)
4,90E-02	4,40E+00
1,40E-01	5,34E-01
8,04E-01	8,02E-02
2,98E-01	2,57E-02
1,69E-01	5,09E-03
1,35E-01	6,41E-04



Inverter Switch Characteristics

figure 5. IGBT

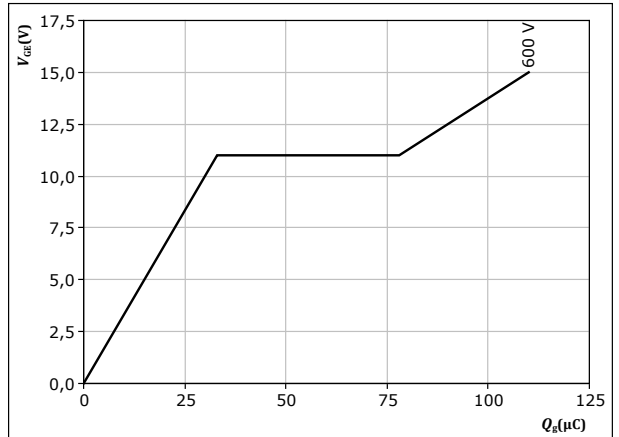
Safe operating area
 $I_C = f(V_{CE})$



$D =$ single pulse
 $T_s = 80 \text{ } ^\circ\text{C}$
 $V_{GE} = 15 \text{ V}$
 $T_j = T_{jmax}$

figure 6. IGBT

Gate voltage vs gate charge
 $V_{GE} = f(Q_g)$



$I_C = 15 \text{ A}$
 $T_j = 25 \text{ } ^\circ\text{C}$



Inverter Diode Characteristics

figure 7. FWD

Typical forward characteristics

$$I_F = f(V_F)$$

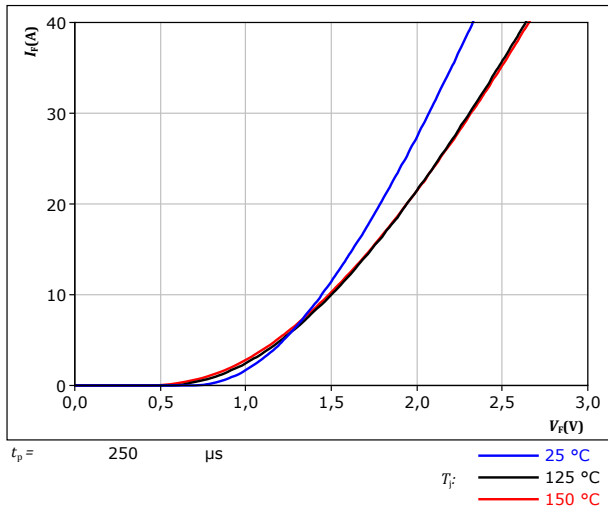
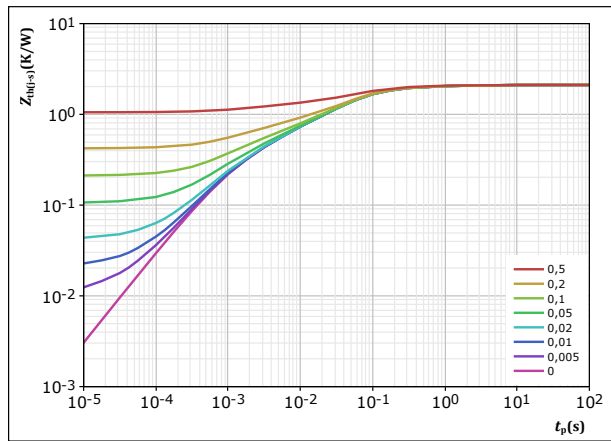


figure 8. FWD

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$
 $R_{th(j-s)} = 2,108$ K/W
 FWD thermal model values

R (K/W)	τ (s)
8,99E-02	2,33E+00
4,04E-01	1,91E-01
1,05E+00	4,49E-02
3,39E-01	6,08E-03
2,29E-01	1,02E-03



Boost Switch Characteristics

figure 9. MOSFET

Typical output characteristics
 $I_D = f(V_{DS})$

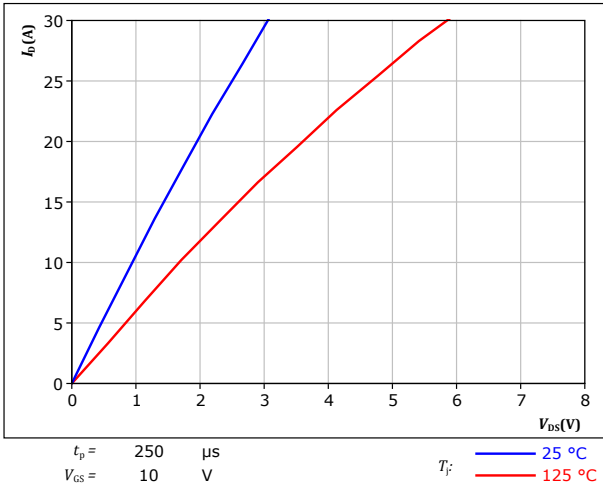


figure 10. MOSFET

Typical output characteristics
 $I_D = f(V_{DS})$

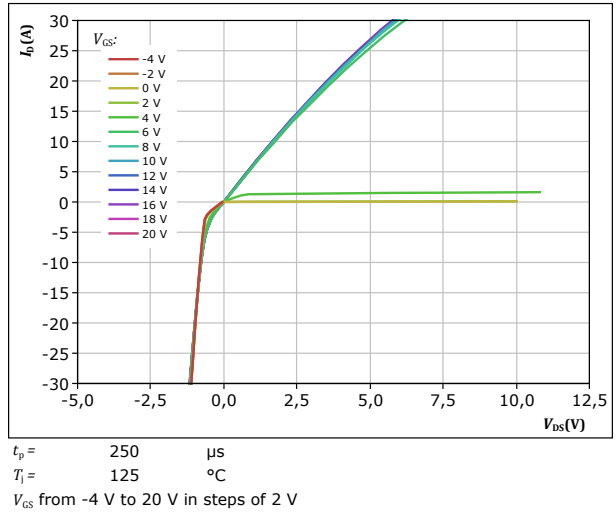


figure 11. MOSFET

Typical transfer characteristics
 $I_D = f(V_{GS})$

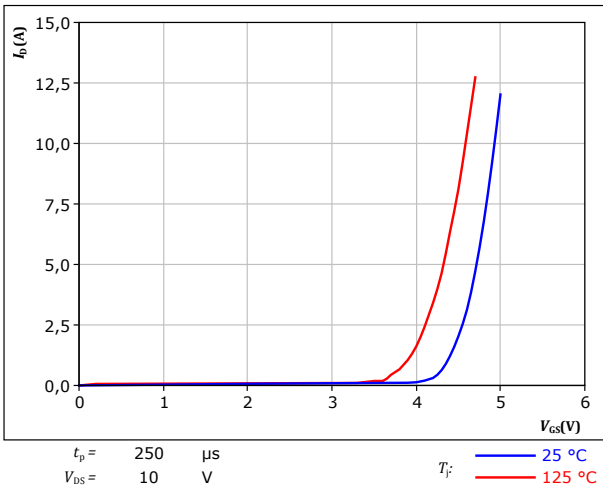
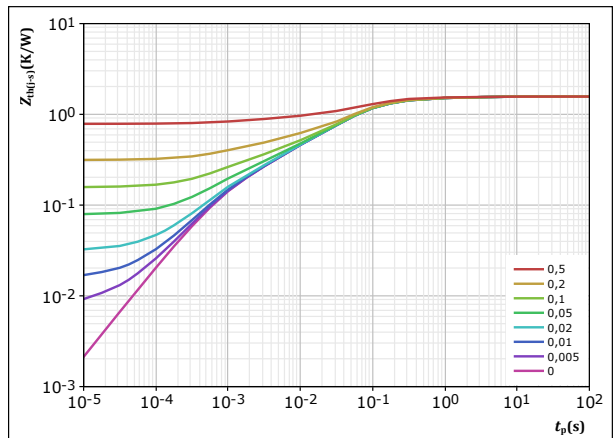


figure 12. MOSFET

Transient thermal impedance as a function of pulse width
 $Z_{th(j-s)} = f(t_p)$



$D = t_p / T$
 $R_{th(j-s)} = 1,57 \text{ K/W}$
 MOSFET thermal model values

R (K/W)	τ (s)
6,39E-02	3,03E+00
2,01E-01	3,38E-01
9,37E-01	6,22E-02
2,33E-01	6,81E-03
1,35E-01	8,27E-04

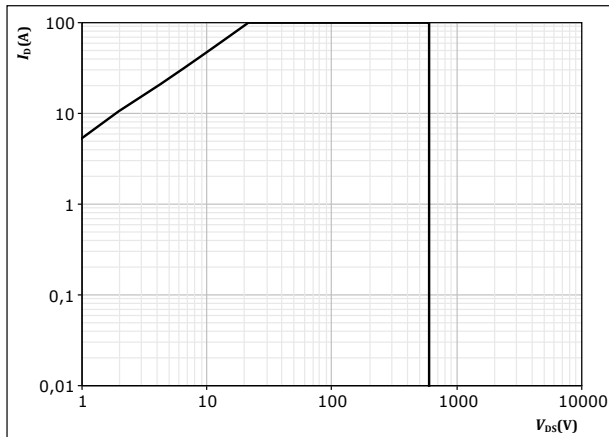


Boost Switch Characteristics

figure 13. MOSFET

Safe operating area

$$I_D = f(V_{DS})$$



$D =$ single pulse
 $T_s = 80 \text{ } ^\circ\text{C}$
 $V_{GS} = 10 \text{ V}$
 $T_j = T_{jmax}$



Boost Diode Characteristics

figure 14. FWD

Typical forward characteristics

$$I_F = f(V_F)$$

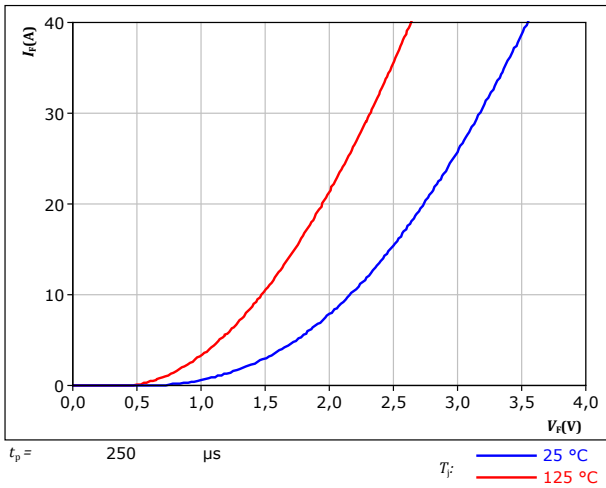
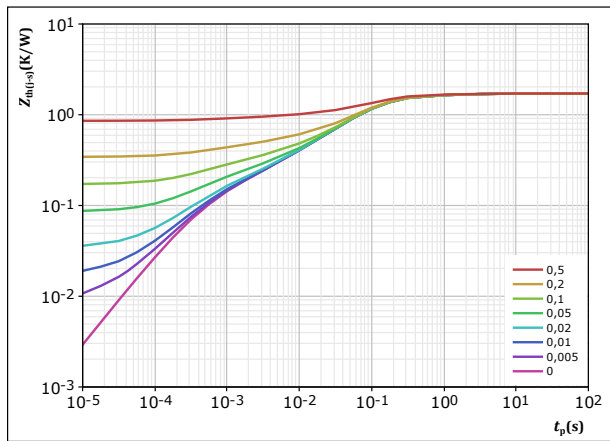


figure 15. FWD

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$

$R_{th(j-s)} = 1,713 \text{ K/W}$

FWD thermal model values

$R \text{ (K/W)}$	$\tau \text{ (s)}$
7,49E-02	2,70E+00
1,69E-01	4,49E-01
9,61E-01	9,37E-02
2,39E-01	3,41E-02
1,24E-01	6,38E-03
7,56E-02	1,23E-03
7,06E-02	3,59E-04



Rectifier Diode Characteristics

figure 16. Rectifier

Typical forward characteristics

$$I_F = f(V_F)$$

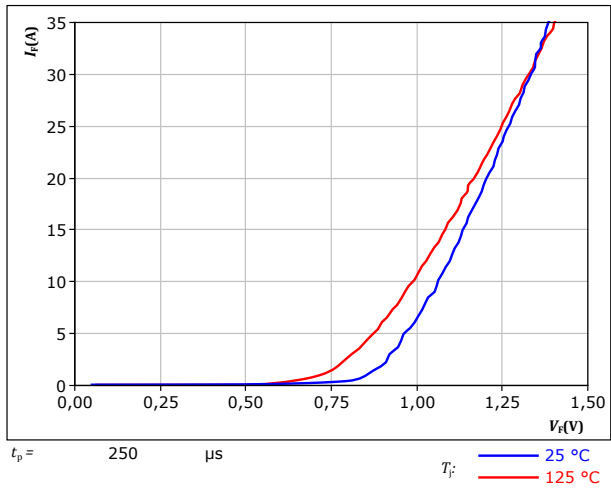
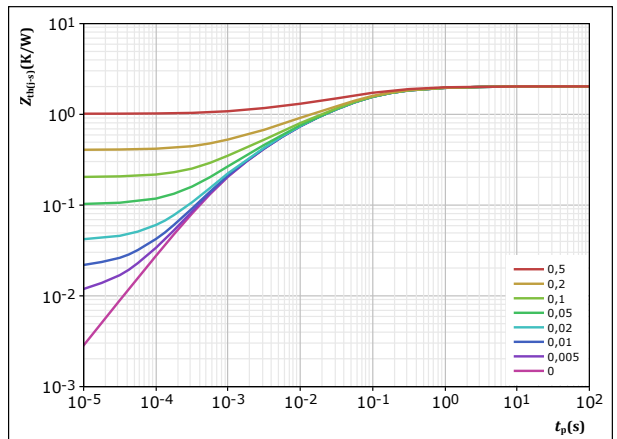


figure 17. Rectifier

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$

$R_{th(j-s)} = 2,032 \text{ K/W}$

Rectifier thermal model values

$R \text{ (K/W)}$	$\tau \text{ (s)}$
1,06E-01	2,32E+00
4,93E-01	2,00E-01
7,85E-01	4,15E-02
4,66E-01	6,59E-03
1,83E-01	9,43E-04

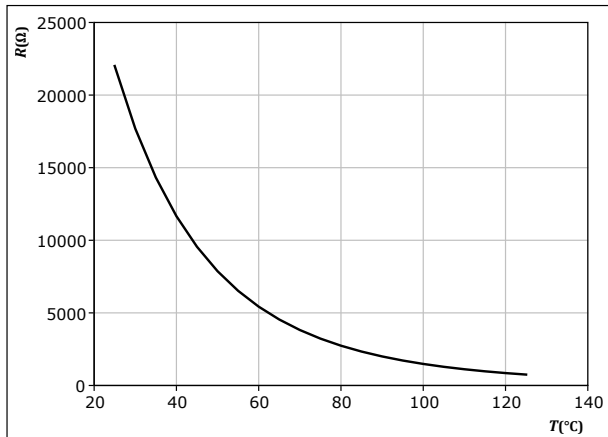


Thermistor Characteristics

figure 18. Thermistor

Typical NTC characteristic as function of temperature

$$R_T = f(T)$$

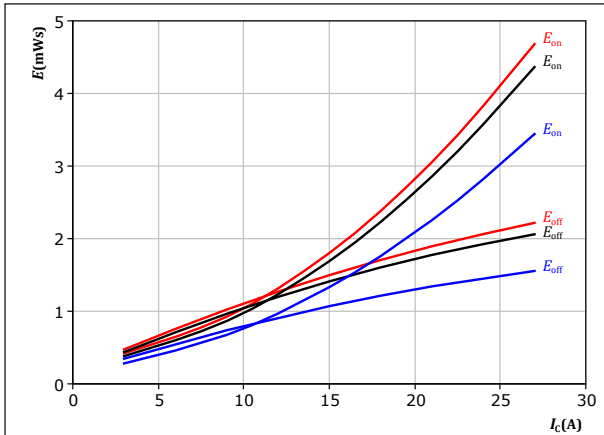




Inverter Switching Characteristics

figure 19. IGBT

Typical switching energy losses as a function of collector current
 $E = f(I_c)$

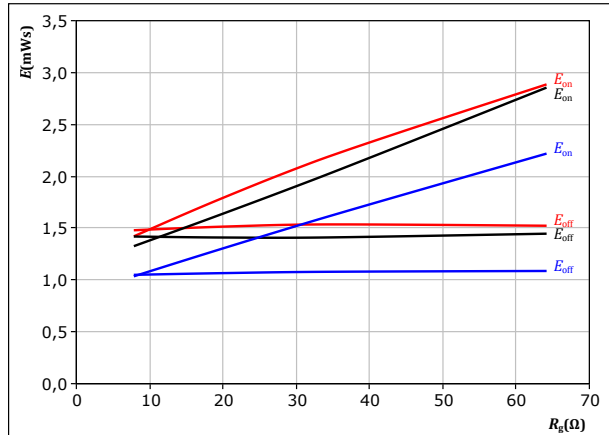


With an inductive load at

$V_{CE} = 600$ V	$T_j:$ 25 °C
$V_{GE} = \pm 15$ V	125 °C
$R_{g(on)} = 21,3$ Ω	150 °C
$R_{g(off)} = 21,3$ Ω	

figure 20. IGBT

Typical switching energy losses as a function of IGBT turn on gate resistor
 $E = f(R_g)$

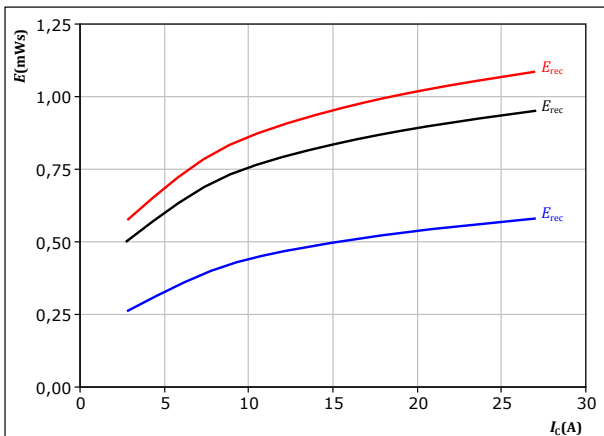


With an inductive load at

$V_{CE} = 600$ V	$T_j:$ 25 °C
$V_{GE} = \pm 15$ V	125 °C
$I_c = 15$ A	150 °C

figure 21. FWD

Typical reverse recovered energy loss as a function of collector current
 $E_{rec} = f(I_c)$

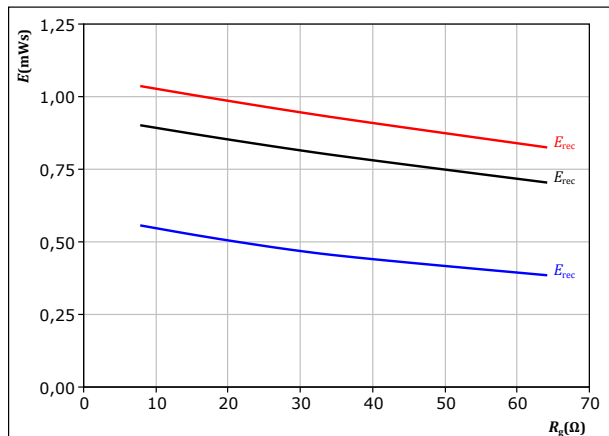


With an inductive load at

$V_{CE} = 600$ V	$T_j:$ 25 °C
$V_{GE} = \pm 15$ V	125 °C
$R_{g(on)} = 21,3$ Ω	150 °C

figure 22. FWD

Typical reverse recovered energy loss as a function of IGBT turn on gate resistor
 $E_{rec} = f(R_g)$



With an inductive load at

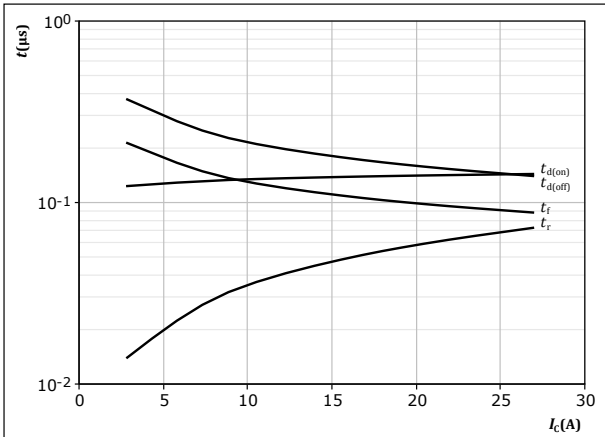
$V_{CE} = 600$ V	$T_j:$ 25 °C
$V_{GE} = \pm 15$ V	125 °C
$I_c = 15$ A	150 °C



Inverter Switching Characteristics

figure 23. IGBT

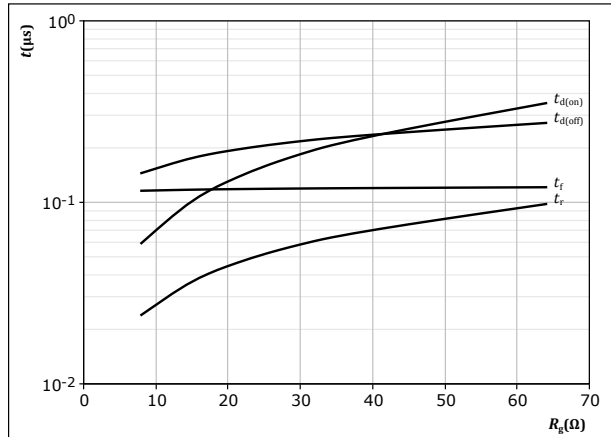
Typical switching times as a function of collector current
 $t = f(I_c)$



With an inductive load at
 $T_j = 150 \text{ }^\circ\text{C}$
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 21,3 \text{ } \Omega$
 $R_{goff} = 21,3 \text{ } \Omega$

figure 24. IGBT

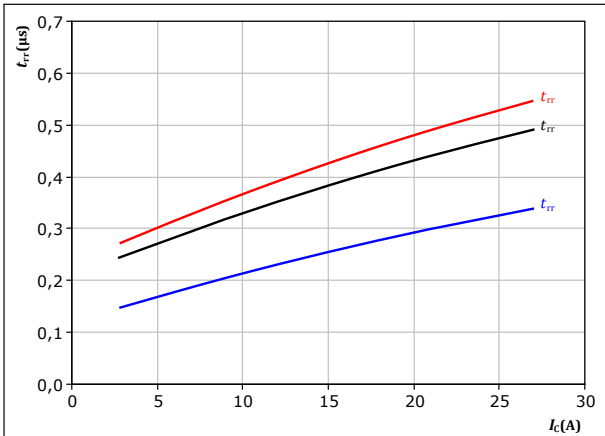
Typical switching times as a function of IGBT turn on gate resistor
 $t = f(R_g)$



With an inductive load at
 $T_j = 150 \text{ }^\circ\text{C}$
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_c = 15 \text{ A}$

figure 25. FWD

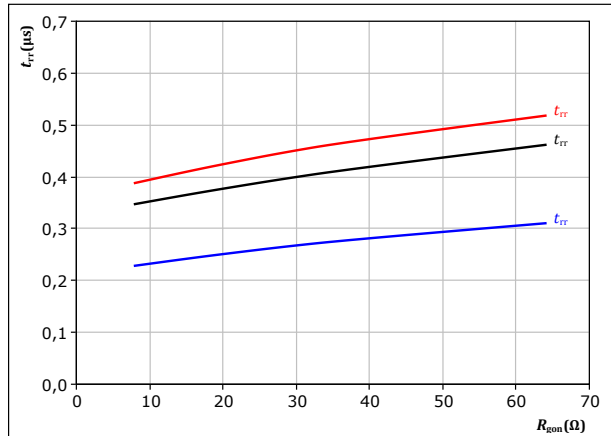
Typical reverse recovery time as a function of collector current
 $t_{rr} = f(I_c)$



With an inductive load at
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 21,3 \text{ } \Omega$
 $T_j:$ — 25 °C
 — 125 °C
 — 150 °C

figure 26. FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor
 $t_{rr} = f(R_{gon})$



With an inductive load at
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_c = 15 \text{ A}$
 $T_j:$ — 25 °C
 — 125 °C
 — 150 °C

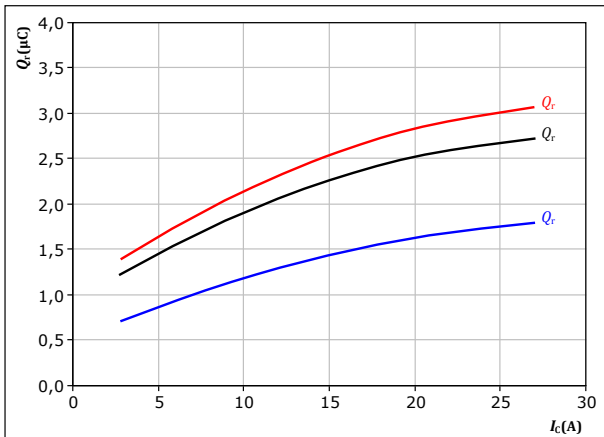


Inverter Switching Characteristics

figure 27. FWD

Typical recovered charge as a function of collector current

$$Q_r = f(I_c)$$



With an inductive load at

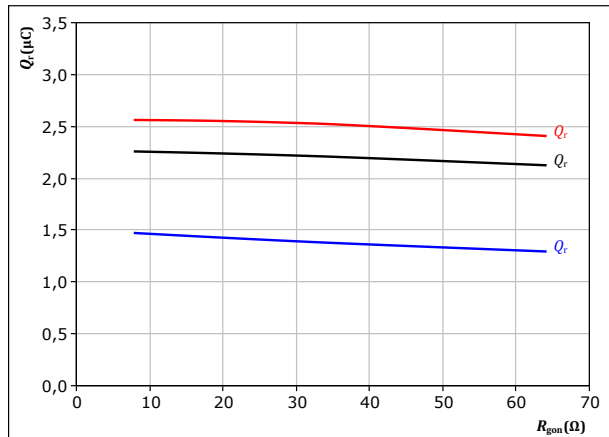
$V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 21,3 \ \Omega$

T_j : — 25 °C
— 125 °C
— 150 °C

figure 28. FWD

Typical recovered charge as a function of IGBT turn on gate resistor

$$Q_r = f(R_{gon})$$



With an inductive load at

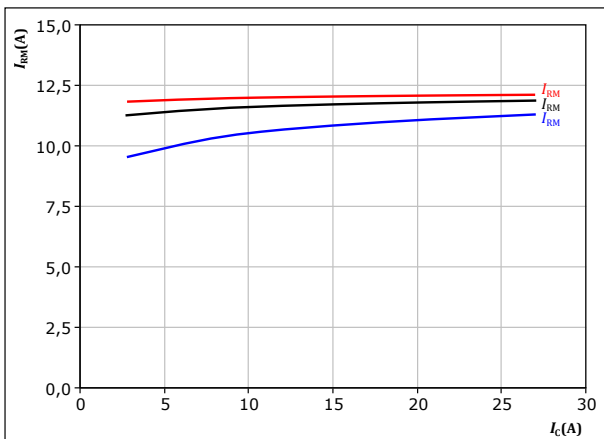
$V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_c = 15 \text{ A}$

T_j : — 25 °C
— 125 °C
— 150 °C

figure 29. FWD

Typical peak reverse recovery current as a function of collector current

$$I_{RM} = f(I_c)$$



With an inductive load at

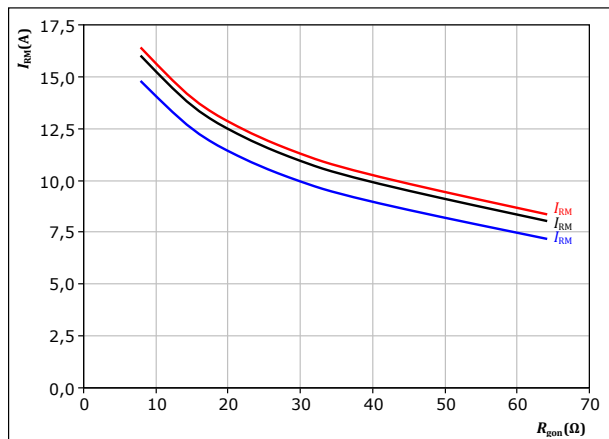
$V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 21,3 \ \Omega$

T_j : — 25 °C
— 125 °C
— 150 °C

figure 30. FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RM} = f(R_{gon})$$



With an inductive load at

$V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_c = 15 \text{ A}$

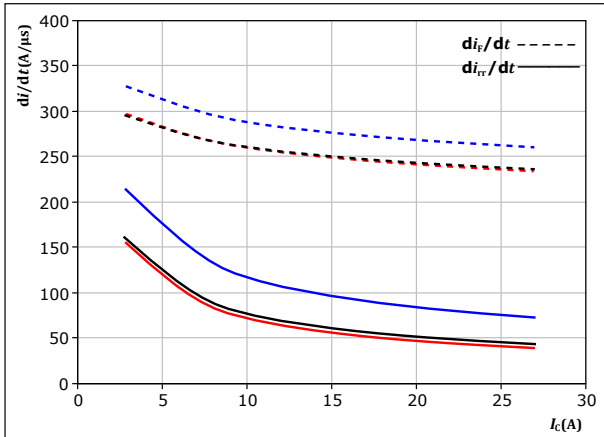
T_j : — 25 °C
— 125 °C
— 150 °C



Inverter Switching Characteristics

figure 31. FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current
 $di_f/dt, di_{rr}/dt = f(I_C)$



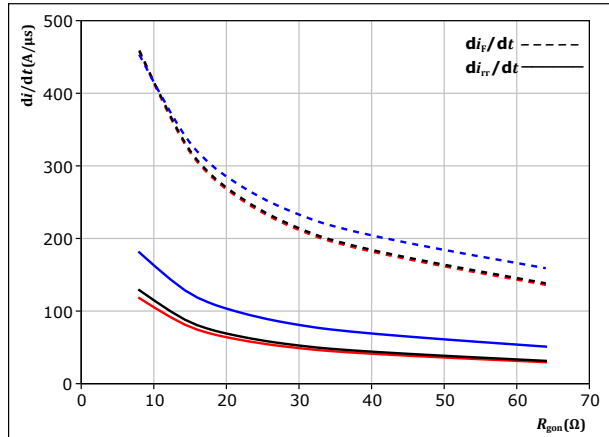
With an inductive load at

$V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 21,3 \ \Omega$

$T_j:$
— 25 °C
— 125 °C
— 150 °C

figure 32. FWD

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor
 $di_f/dt, di_{rr}/dt = f(R_{gon})$



With an inductive load at

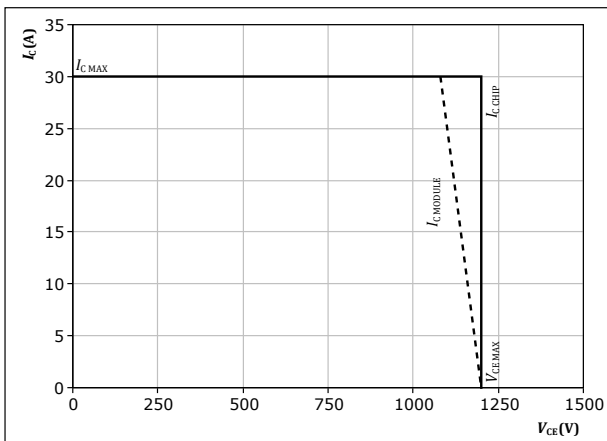
$V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_C = 15 \text{ A}$

$T_j:$
— 25 °C
— 125 °C
— 150 °C

figure 33. IGBT

Reverse bias safe operating area

$I_C = f(V_{CE})$



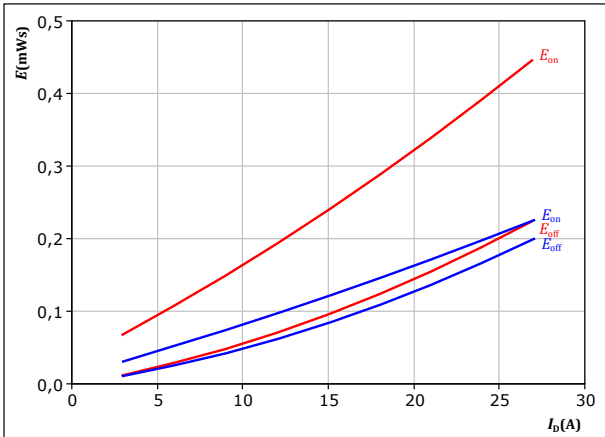
At $T_j = 150 \text{ °C}$
 $R_{gon} = 21,3 \ \Omega$
 $R_{goff} = 21,3 \ \Omega$



Boost Switching Characteristics

figure 34. MOSFET

Typical switching energy losses as a function of drain current
 $E = f(I_D)$



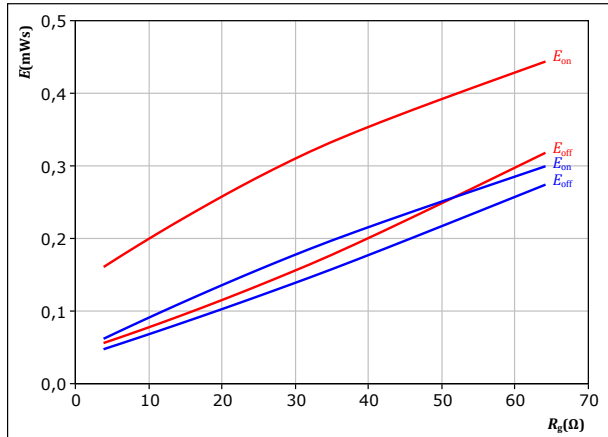
With an inductive load at

$V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $R_{gon} = 16$ Ω
 $R_{goff} = 16$ Ω

T_j : — 25 °C
— 125 °C

figure 35. MOSFET

Typical switching energy losses as a function of MOSFET turn on gate resistor
 $E = f(R_g)$



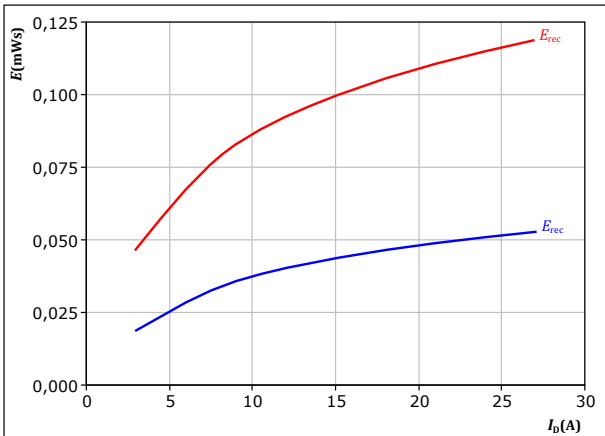
With an inductive load at

$V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $I_D = 15$ A

T_j : — 25 °C
— 125 °C

figure 36. MOSFET

Typical reverse recovered energy loss as a function of drain current
 $E_{rec} = f(I_D)$



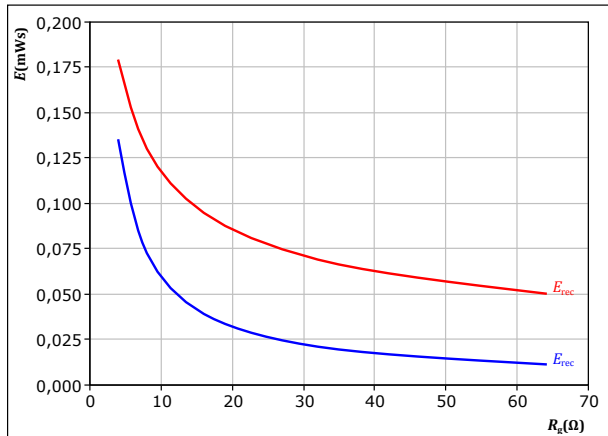
With an inductive load at

$V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $R_{gon} = 16$ Ω

T_j : — 25 °C
— 125 °C

figure 37. MOSFET

Typical reverse recovered energy loss as a function of MOSFET turn on gate resistor
 $E_{rec} = f(R_g)$



With an inductive load at

$V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $I_D = 15$ A

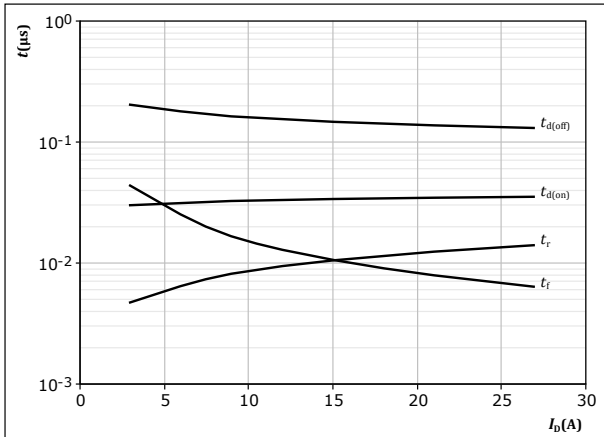
T_j : — 25 °C
— 125 °C



Boost Switching Characteristics

figure 38. MOSFET

Typical switching times as a function of drain current
 $t = f(I_D)$

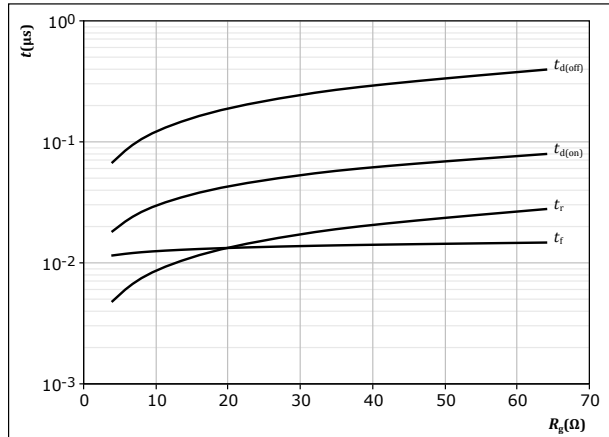


With an inductive load at

$T_j = 125 \text{ } ^\circ\text{C}$
 $V_{DS} = 400 \text{ V}$
 $V_{GS} = 0/10 \text{ V}$
 $R_{gon} = 16 \text{ } \Omega$
 $R_{goff} = 16 \text{ } \Omega$

figure 39. MOSFET

Typical switching times as a function of MOSFET turn on gate resistor
 $t = f(R_g)$

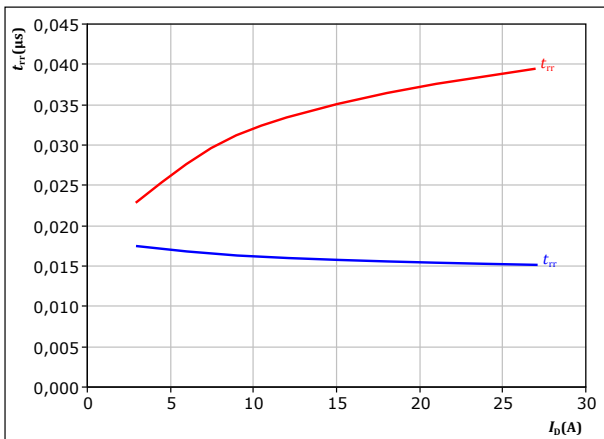


With an inductive load at

$T_j = 125 \text{ } ^\circ\text{C}$
 $V_{DS} = 400 \text{ V}$
 $V_{GS} = 0/10 \text{ V}$
 $I_D = 15 \text{ A}$

figure 40. MOSFET

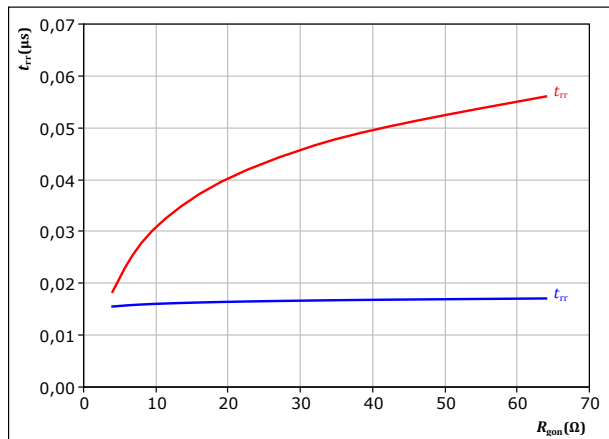
Typical reverse recovery time as a function of drain current
 $t_{rr} = f(I_D)$



At $V_{DS} = 400 \text{ V}$
 $V_{GS} = 0/10 \text{ V}$
 $R_{gon} = 16 \text{ } \Omega$
 T_j : — 25 °C
— 125 °C

figure 41. MOSFET

Typical reverse recovery time as a function of MOSFET turn on gate resistor
 $t_{rr} = f(R_{gon})$



At $V_{DS} = 400 \text{ V}$
 $V_{GS} = 0/10 \text{ V}$
 $I_D = 15 \text{ A}$
 T_j : — 25 °C
— 125 °C

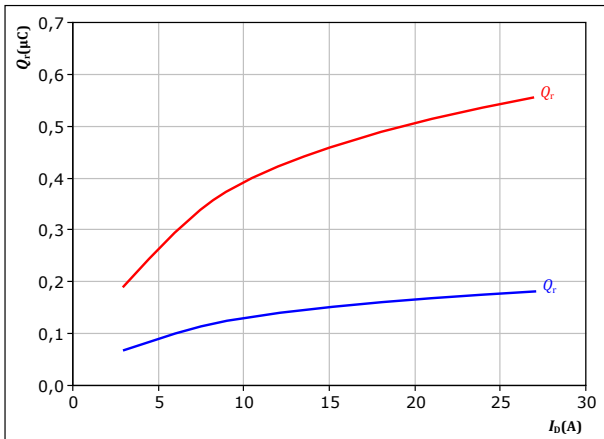


Boost Switching Characteristics

figure 42. MOSFET

Typical recovered charge as a function of drain current

$$Q_r = f(I_D)$$

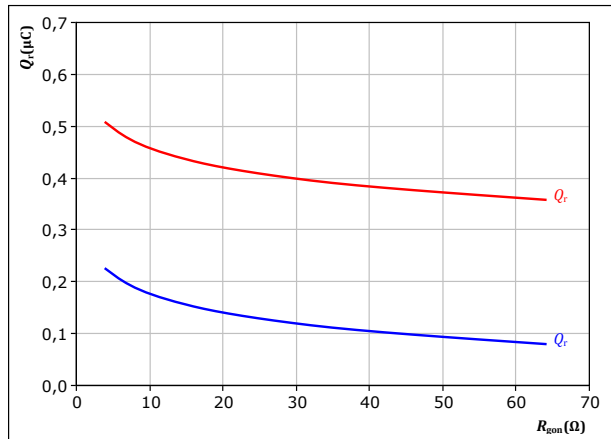


At $V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $R_{gon} = 16$ Ω
 T_j : — 25 °C
 — 125 °C

figure 43. MOSFET

Typical recovered charge as a function of MOSFET turn on gate resistor

$$Q_r = f(R_{gon})$$

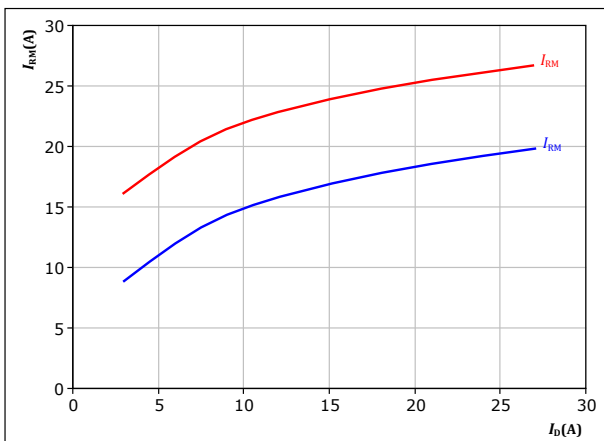


At $V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $I_D = 15$ A
 T_j : — 25 °C
 — 125 °C

figure 44. MOSFET

Typical peak reverse recovery current as a function of drain current

$$I_{RM} = f(I_D)$$

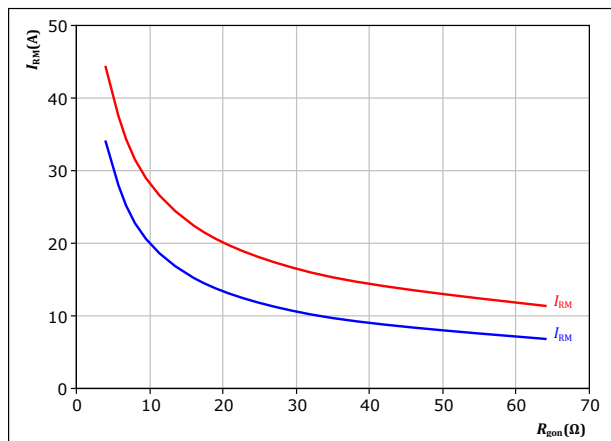


At $V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $R_{gon} = 16$ Ω
 T_j : — 25 °C
 — 125 °C

figure 45. MOSFET

Typical peak reverse recovery current as a function of MOSFET turn on gate resistor

$$I_{RM} = f(R_{gon})$$



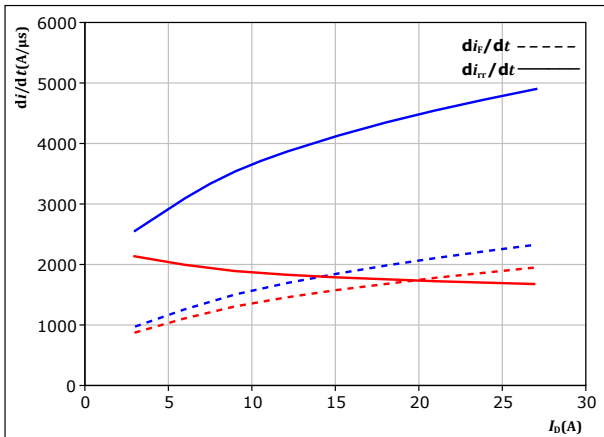
At $V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $I_D = 15$ A
 T_j : — 25 °C
 — 125 °C



Boost Switching Characteristics

figure 46. MOSFET

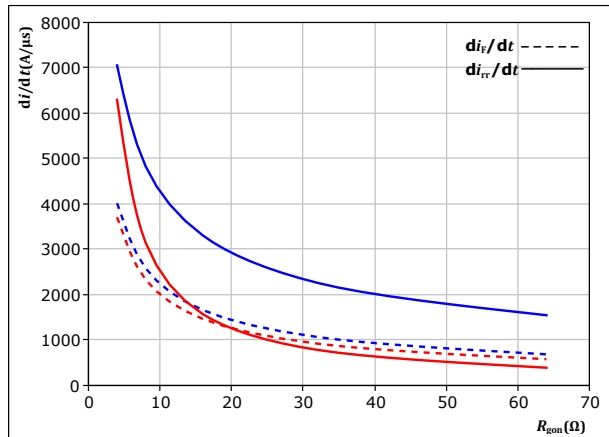
Typical rate of fall of forward and reverse recovery current as a function of drain current
 $di_f/dt, di_{rr}/dt = f(I_D)$



At $V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $R_{g(on)} = 16$ Ω
 $T_j: 25$ °C
 125 °C

figure 47. MOSFET

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor
 $di_f/dt, di_{rr}/dt = f(R_{g(on)})$

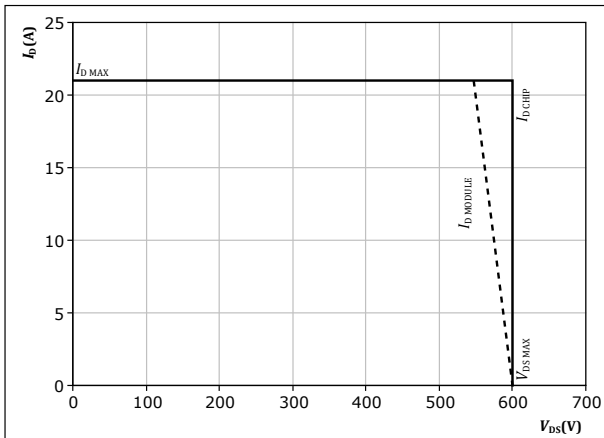


At $V_{DS} = 400$ V
 $V_{GS} = 0/10$ V
 $I_D = 15$ A
 $T_j: 25$ °C
 125 °C

figure 48. MOSFET

Reverse bias safe operating area

$I_D = f(V_{DS})$



At $T_j = 125$ °C
 $R_{g(on)} = 16$ Ω
 $R_{g(off)} = 16$ Ω



Inverter Switching Definitions

figure 49. IGBT
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})

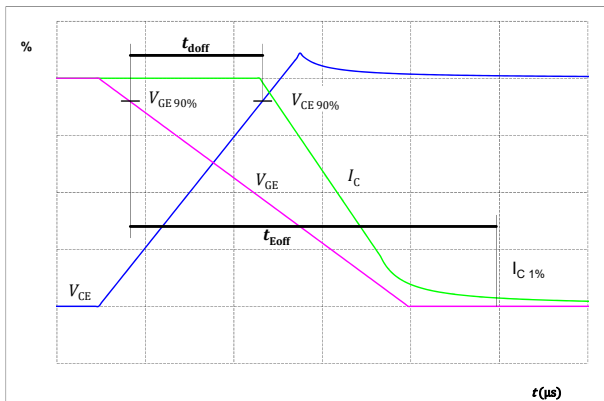


figure 50. IGBT
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})

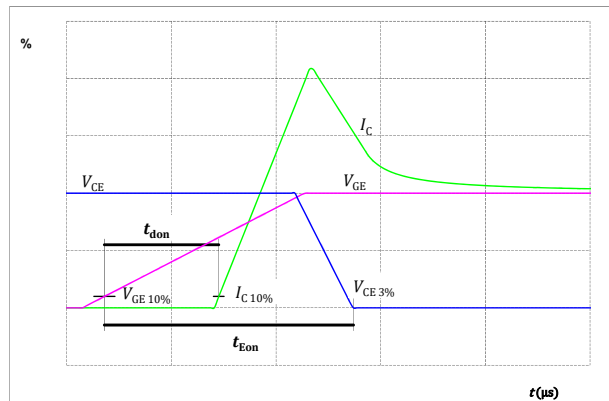


figure 51. IGBT
Turn-off Switching Waveforms & definition of t_f

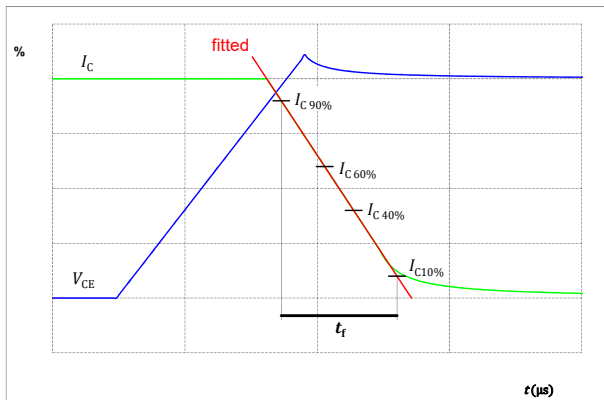
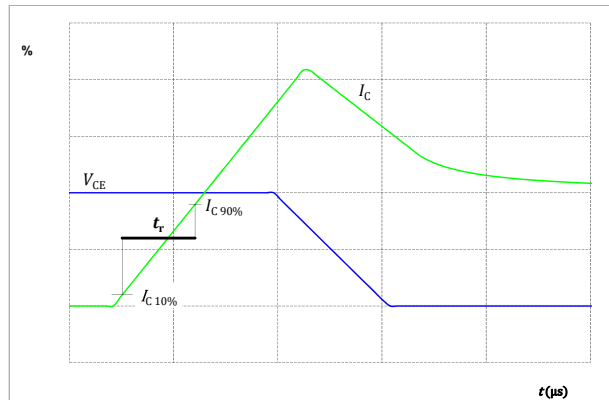


figure 52. IGBT
Turn-on Switching Waveforms & definition of t_r





Inverter Switching Definitions

figure 53. FWD

Turn-off Switching Waveforms & definition of t_{rr}

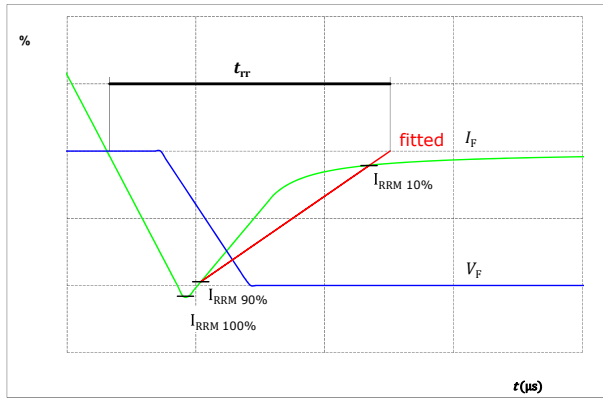
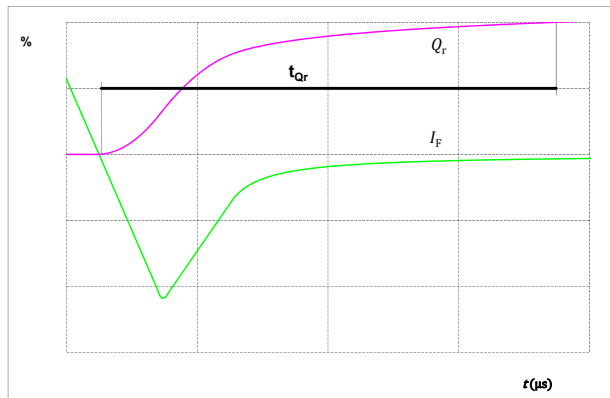


figure 54. FWD

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)





Boost Switching Definitions

figure 49. MOSFET

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})

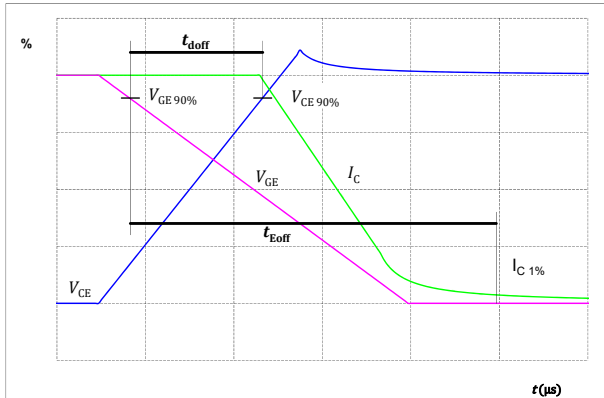


figure 50. MOSFET

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})

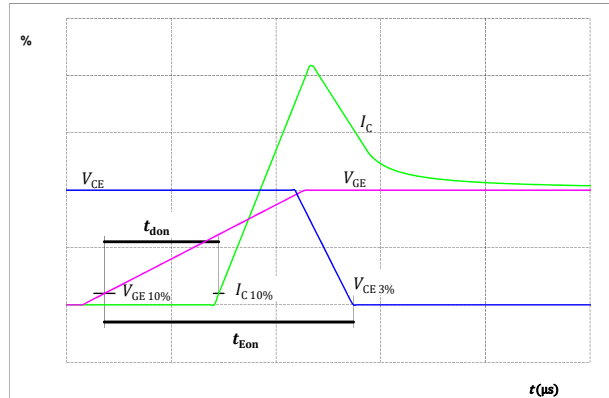


figure 51. MOSFET

Turn-off Switching Waveforms & definition of t_f

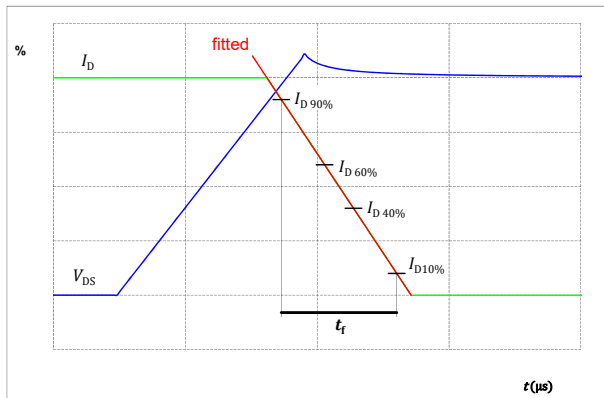
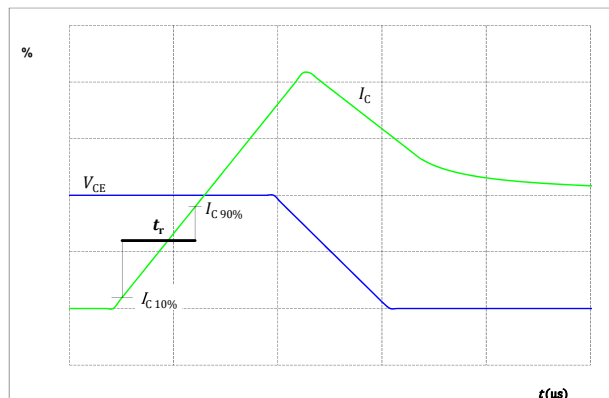


figure 52. MOSFET

Turn-on Switching Waveforms & definition of t_r





Boost Switching Definitions

figure 53. FWD

Turn-off Switching Waveforms & definition of t_{tr}

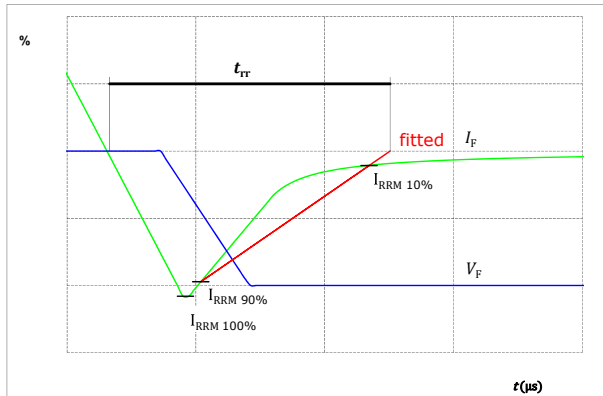


figure 54. FWD

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)

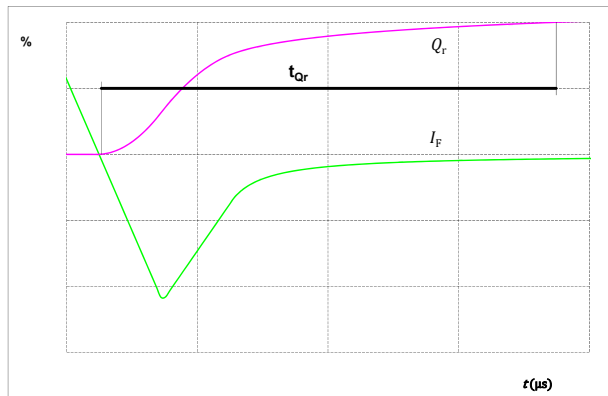
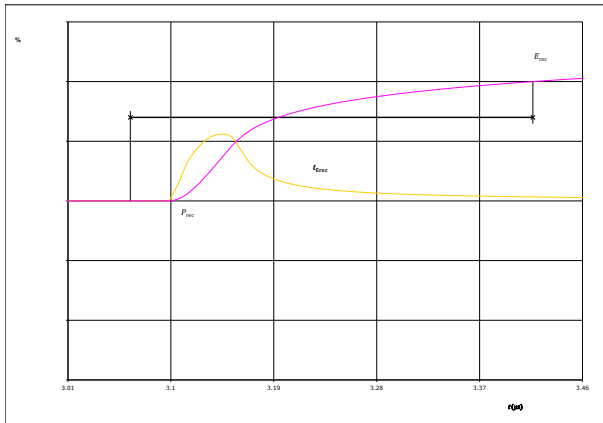


figure 55. FWD

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec} = integrating time for E_{rec})






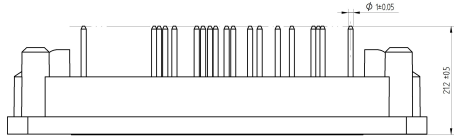
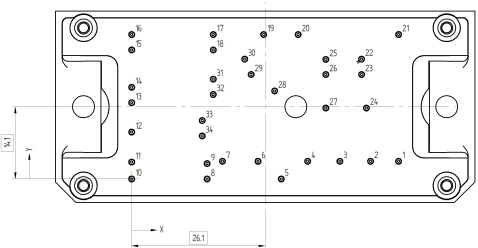
Vincotech

10-F112VPA015M7-LK88A74
datasheet

Ordering Code	
Version	Ordering Code
Without thermal paste	10-F112VPA015M7-LK88A74
With thermal paste (5,2 W/mK, PTM6000HV)	10-F112VPA015M7-LK88A74-/7/
With thermal paste (3,4 W/mK, PSX-P7)	10-F112VPA015M7-LK88A74-/3/

Marking					
Text	Name	Date code	UL & VIN	Lot	Serial
		NN-NNNNNNNNNNNNNNN- TTTTTVV	WWYY	UL VIN	LLLLL
Datamatrix		Type&Ver	Lot number	Serial	Date code
	TTTTTVV	LLLLL	SSSS	WWYY	

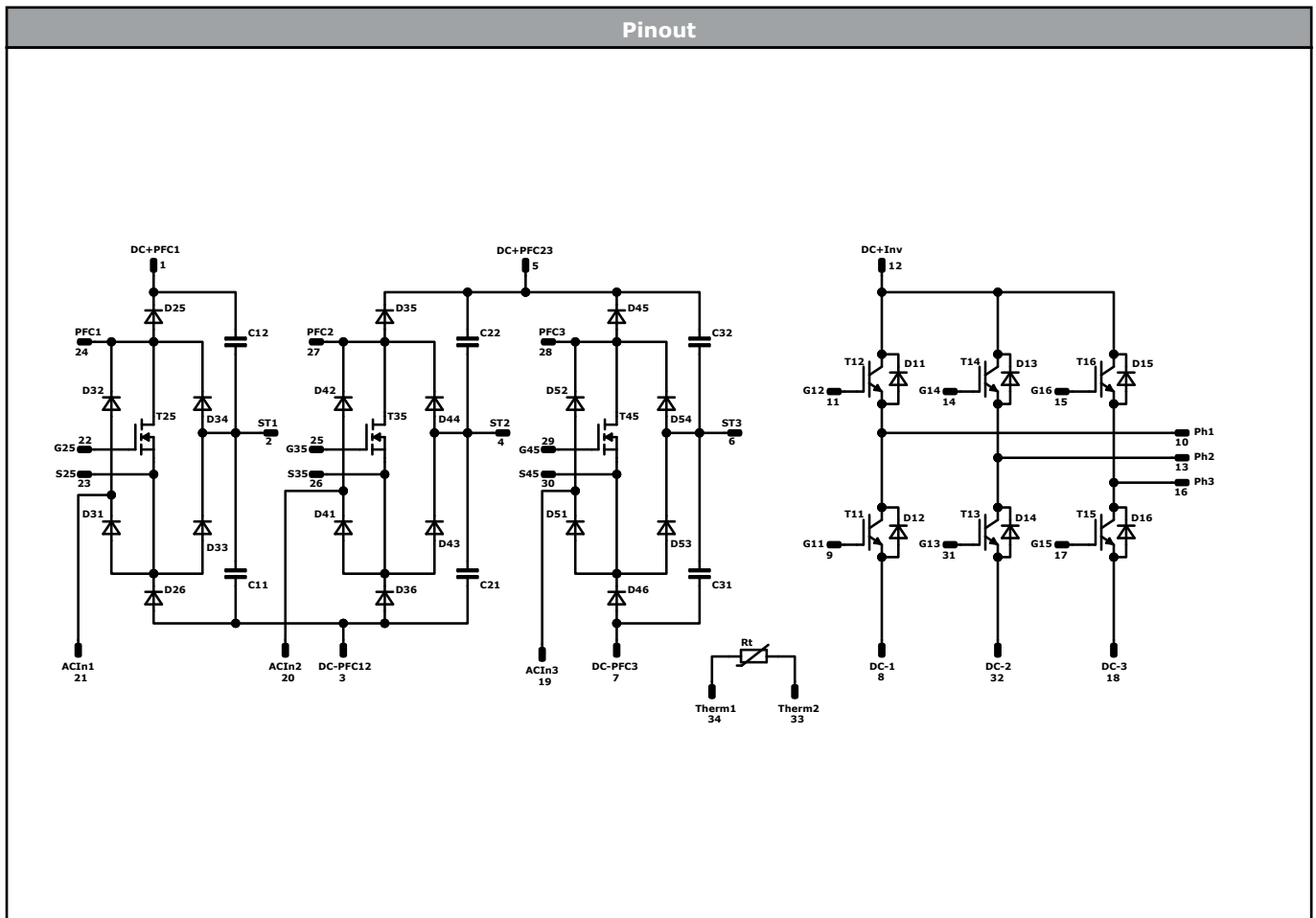
Outline			
Pin table [mm]			
Pin	X	Y	Function
1	52,2	3,45	DC+PFC1
2	46,7	3,45	ST1
3	40,7	3,45	DC-PFC12
4	34,4	3,45	ST2
5	29,25	0	DC+PFC23
6	24,7	3,45	ST3
7	17,75	3,45	DC-PFC3
8	14,75	0	DC-1
9	14,75	3	G11
10	0	0	Ph1
11	0	3,3	G12
12	0	9,15	DC+Inv
13	0	14,9	Ph2
14	0	17,9	G14
15	0	25,2	G16
16	0	28,2	Ph3
17	15,95	28,2	G15
18	15,95	25,2	DC-3
19	25,8	28,2	ACIn3
20	32,55	28,2	ACIn2
21	52,2	28,2	ACIn1
22	44,95	23,4	G25
23	44,95	20,4	S25
24	45,9	13,85	PFC1
25	37,95	23,35	G35
26	37,95	20,4	S35
27	37,95	13,85	PFC2
28	27,95	17,2	PFC3
29	23,35	20,4	G45
30	22,1	23,4	S45
31	15,95	19,5	G13
32	15,95	16,5	DC-2
33	13,8	11,4	Therm2
34	13,8	8,4	Therm1

Tolerance of pinposition: ±0,05mm at the end of pins
Dimension of coordinate axis is only offset without tolerance



Vincotech



Identification					
ID	Component	Voltage	Current	Function	Comment
T11, T12, T13, T14, T15, T16	IGBT	1200 V	15 A	Inverter Switch	
D11, D12, D13, D14, D15, D16	FWD	1200 V	15 A	Inverter Diode	
T25, T35, T45	MOSFET	600 V	77 mΩ	Boost Switch	
D25, D35, D45, D26, D36, D46	FWD	600 V	15 A	Boost Diode	
D31, D32, D33, D34, D41, D42, D43, D44, D51, D52, D53, D54	Rectifier	1600 V	12 A	Rectifier Diode	
C11, C12, C21, C22, C31, C32	Capacitor	630 V		Capacitor (DC)	
Rt	Thermistor			Thermistor	




Packaging instruction				
Standard packaging quantity (SPQ) 100	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for <i>flow 1</i> packages see vincotech.com website.

Package data
Package data for <i>flow 1</i> packages see vincotech.com website.

Vincotech thermistor reference
See Vincotech thermistor reference table at vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website. 

Document No.:	Date:	Modification:	Pages
10-F112VPA015M7-LK88A74-D3-14	3 Jun. 2022	Change Boost Diode, Rectifier Diode	

DISCLAIMER

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.